



# Standard Practice for Statistical Analysis of Linear or Linearized Stress-Life ( $S-N$ ) and Strain-Life ( $\epsilon-N$ ) Fatigue Data<sup>1</sup>

This standard is issued under the fixed designation E739; the number immediately following the designation indicates the year of original adoption or, in the case of revision, the year of last revision. A number in parentheses indicates the year of last reapproval. A superscript epsilon ( $\epsilon$ ) indicates an editorial change since the last revision or reapproval.

## 1. Scope

1.1 This practice covers only  $S-N$  and  $\epsilon-N$  relationships that may be reasonably approximated by a straight line (on appropriate coordinates) for a specific interval of stress or strain. It presents elementary procedures that presently reflect good practice in modeling and analysis. However, because the actual  $S-N$  or  $\epsilon-N$  relationship is approximated by a straight line only within a specific interval of stress or strain, and because the actual fatigue life distribution is unknown, it is *not recommended* that (a) the  $S-N$  or  $\epsilon-N$  curve be extrapolated outside the interval of testing, or (b) the fatigue life at a specific stress or strain amplitude be estimated below approximately the fifth percentile ( $P \approx 0.05$ ). As alternative fatigue models and statistical analyses are continually being developed, later revisions of this practice may subsequently present analyses that permit more complete interpretation of  $S-N$  and  $\epsilon-N$  data.

## 2. Referenced Documents

### 2.1 ASTM Standards:<sup>2</sup>

[E206 Definitions of Terms Relating to Fatigue Testing and the Statistical Analysis of Fatigue Data](#)<sup>3</sup>

[E468 Practice for Presentation of Constant Amplitude Fatigue Test Results for Metallic Materials](#)

[E513 Definitions of Terms Relating to Constant-Amplitude, Low-Cycle Fatigue Testing](#)<sup>3</sup>

[E606 Practice for Strain-Controlled Fatigue Testing](#)

## 3. Terminology

3.1 The terms used in this practice shall be used as defined in Definitions [E206](#) and [E513](#). In addition, the following terminology is used:

<sup>1</sup> This practice is under the jurisdiction of ASTM Committee [E08](#) on Fatigue and Fracture and is the direct responsibility of Subcommittee [E08.04](#) on Structural Applications.

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<sup>2</sup> For referenced ASTM standards, visit the ASTM website, [www.astm.org](http://www.astm.org), or contact ASTM Customer Service at [service@astm.org](mailto:service@astm.org). For *Annual Book of ASTM Standards* volume information, refer to the standard's Document Summary page on the ASTM website.

<sup>3</sup> Withdrawn. The last approved version of this historical standard is referenced on [www.astm.org](http://www.astm.org).

3.1.1 *dependent variable*—the fatigue life  $N$  (or the logarithm of the fatigue life).

3.1.1.1 *Discussion*—Log ( $N$ ) is denoted  $Y$  in this practice.

3.1.2 *independent variable*—the selected and controlled variable (namely, stress or strain). It is denoted  $X$  in this practice when plotted on appropriate coordinates.

3.1.3 *log-normal distribution*—the distribution of  $N$  when log ( $N$ ) is normally distributed. (Accordingly, it is convenient to analyze log ( $N$ ) using methods based on the normal distribution.)

3.1.4 *replicate (repeat) tests*—nominally identical tests on different randomly selected test specimens conducted at the same nominal value of the independent variable  $X$ . Such replicate or repeat tests should be conducted independently; for example, each replicate test should involve a separate set of the test machine and its settings.

3.1.5 *run out*—no failure at a specified number of load cycles (Practice [E468](#)).

3.1.5.1 *Discussion*—The analyses illustrated in this practice do not apply when the data include either run-outs (or suspended tests). Moreover, the straight-line approximation of the  $S-N$  or  $\epsilon-N$  relationship may not be appropriate at long lives when run-outs are likely.

3.1.5.2 *Discussion*—For purposes of statistical analysis, a run-out may be viewed as a test specimen that has either been removed from the test or is still running at the time of the data analysis.

## 4. Significance and Use

4.1 Materials scientists and engineers are making increased use of statistical analyses in interpreting  $S-N$  and  $\epsilon-N$  fatigue data. Statistical analysis applies when the given data can be reasonably assumed to be a random sample of (or representation of) some specific defined population or universe of material of interest (under specific test conditions), and it is desired either to characterize the material or to predict the performance of future random samples of the material (under similar test conditions), or both.

5. Types of *S-N* and  $\epsilon-N$  Curves Considered

5.1 It is well known that the shape of *S-N* and  $\epsilon-N$  curves can depend markedly on the material and test conditions. This practice is restricted to linear or linearized *S-N* and  $\epsilon-N$  relationships, for example,

$$\log N = A + B(S) \text{ or} \tag{1}$$

$$\log N = A + B(\epsilon) \text{ or}$$

$$\log N = A + B(\log S) \text{ or} \tag{2}$$

$$\log N = A + B(\log \epsilon)$$

in which *S* and  $\epsilon$  may refer to (a) the maximum value of constant-amplitude cyclic stress or strain, given a specific value of the stress or strain ratio, or of the minimum cyclic stress or strain, (b) the amplitude or the range of the constant-amplitude cyclic stress or strain, given a specific value of the mean stress or strain, or (c) analogous information stated in terms of some appropriate independent (controlled) variable.

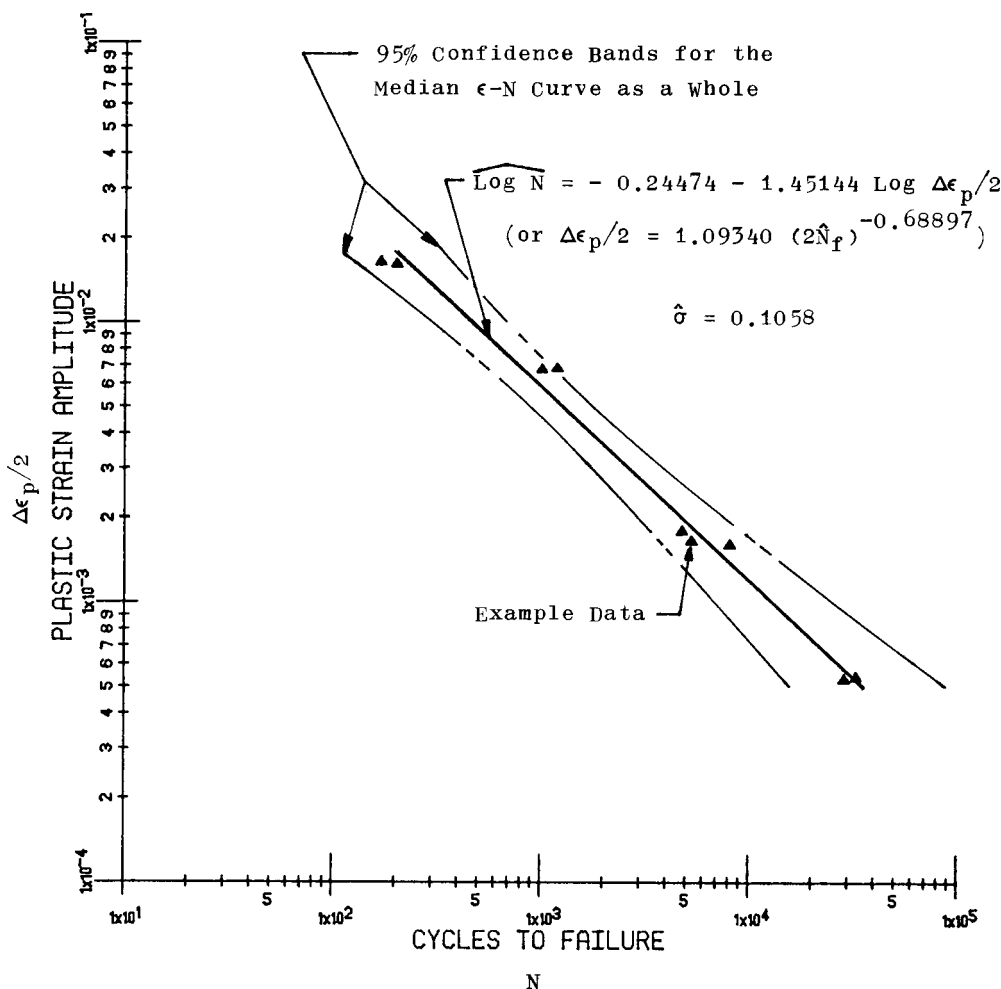
NOTE 1—In certain cases, the amplitude of the stress or strain is not constant during the entire test for a given specimen. In such cases some effective (equivalent) value of *S* or  $\epsilon$  must be established for use in analysis.

5.1.1 The fatigue life *N* is the dependent (random) variable in *S-N* and  $\epsilon-N$  tests, whereas *S* or  $\epsilon$  is the independent (controlled) variable.

NOTE 2—In certain cases, the independent variable used in analysis is not literally the variable controlled during testing. For example, it is common practice to analyze low-cycle fatigue data treating the range of plastic strain as the controlled variable, when in fact the range of total strain was actually controlled during testing. Although there may be some question regarding the exact nature of the controlled variable in certain *S-N* and  $\epsilon-N$  tests, there is never any doubt that the fatigue life is the dependent variable.

NOTE 3—In plotting *S-N* and  $\epsilon-N$  curves, the independent variables *S* and  $\epsilon$  are plotted along the ordinate, with life (the dependent variable) plotted along the abscissa. Refer, for example, to Fig. 1.

5.1.2 The distribution of fatigue life (in any test) is unknown (and indeed may be quite complex in certain situations). For the purposes of simplifying the analysis (while maintaining sound statistical procedures), it is assumed in this practice that the logarithms of the fatigue lives are normally distributed, that is, the fatigue life is log-normally distributed, and that the variance of log life is constant over the entire range of the independent variable used in testing (that is, the scatter in log



NOTE 1—The 95% confidence band for the  $\epsilon-N$  curve as a whole is based on Eq 10. (Note that the dependent variable, fatigue life, is plotted here along the abscissa to conform to engineering convention.)

FIG. 1 Fitted Relationship Between the Fatigue Life *N* (Y) and the Plastic Strain Amplitude  $\Delta\epsilon_p/2$  (X) for the Example Data Given

$N$  is assumed to be the same at low  $S$  and  $\varepsilon$  levels as at high levels of  $S$  or  $\varepsilon$ ). Accordingly,  $\log N$  is used as the dependent (random) variable in analysis. It is denoted  $Y$ . The independent variable is denoted  $X$ . It may be either  $S$  or  $\varepsilon$ , or  $\log S$  or  $\log \varepsilon$ , respectively, depending on which appears to produce a straight line plot for the interval of  $S$  or  $\varepsilon$  of interest. Thus Eq 1 and Eq 2 may be re-expressed as

$$Y = A + BX \quad (3)$$

Eq 3 is used in subsequent analysis. It may be stated more precisely as  $\mu_{Y|X} = A + BX$ , where  $\mu_{Y|X}$  is the expected value of  $Y$  given  $X$ .

NOTE 4—For testing the adequacy of the linear model, see 8.2.

NOTE 5—The expected value is the mean of the conceptual population of all  $Y$ 's given a specific level of  $X$ . (The median and mean are identical for the symmetrical normal distribution assumed in this practice for  $Y$ .)

## 6. Test Planning

6.1 Test planning for  $S$ - $N$  and  $\varepsilon$ - $N$  test programs is discussed in Chapter 3 of Ref (1).<sup>4</sup> Planned grouping (blocking) and randomization are essential features of a well-planned test program. In particular, good test methodology involves use of planned grouping to (a) balance potentially spurious effects of nuisance variables (for example, laboratory humidity) and (b) allow for possible test equipment malfunction during the test program.

## 7. Sampling

7.1 It is vital that sampling procedures be adopted that assure a random sample of the material being tested. A random sample is required to state that the test specimens are representative of the conceptual universe about which both statistical and engineering inference will be made.

NOTE 6—A random sampling procedure provides each specimen that conceivably could be selected (tested) an equal (or known) opportunity of actually being selected at each stage of the sampling process. Thus, it is poor practice to use specimens from a single source (plate, heat, supplier) when seeking a random sample of the material being tested unless that particular source is of specific interest.

NOTE 7—Procedures for using random numbers to obtain random samples and to assign stress or strain amplitudes to specimens (and to establish the time order of testing) are given in Chapter 4 of Ref (2).

7.1.1 *Sample Size*—The minimum number of specimens required in  $S$ - $N$  (and  $\varepsilon$ - $N$ ) testing depends on the type of test program conducted. The following guidelines given in Chapter 3 of Ref (1) appear reasonable.

Type of Test	Minimum Number of Specimens <sup>4</sup>
Preliminary and exploratory (exploratory research and development tests)	6 to 12
Research and development testing of components and specimens	6 to 12
Design allowables data	12 to 24
Reliability data	12 to 24

<sup>4</sup> If the variability is large, a wide confidence band will be obtained unless a large number of specimens are tested (See 8.1.1).

<sup>4</sup> The boldface numbers in parentheses refer to the list of references appended to this standard.

7.1.2 *Replication*—The replication guidelines given in Chapter 3 of Ref (1) are based on the following definition:

% replication = 100 [1 - (total number of different stress or strain levels used in testing/total number of specimens tested)]

Type of Test	Percent Replication <sup>4</sup>
Preliminary and exploratory (research and development tests)	17 to 33 min
Research and development testing of components and specimens	33 to 50 min
Design allowables data	50 to 75 min
Reliability data	75 to 88 min

<sup>4</sup> Note that percent replication indicates the portion of the total number of specimens tested that may be used for obtaining an estimate of the variability of replicate tests.

7.1.2.1 *Replication Examples*—Good replication: Suppose that ten specimens are used in research and development for the testing of a component. If two specimens are tested at each of five stress or strain amplitudes, the test program involves 50 % replications. This percent replication is considered adequate for most research and development applications. Poor replication: Suppose eight different stress or strain amplitudes are used in testing, with two replicates at each of two stress or strain amplitudes (and no replication at the other six stress or strain amplitudes). This test program involves only 20 % replication, which is not generally considered adequate.

## 8. Statistical Analysis (Linear Model $Y = A + BX$ , Log-Normal Fatigue Life Distribution with Constant Variance Along the Entire Interval of $X$ Used in Testing, No Runouts or Suspended Tests or Both, Completely Randomized Design Test Program)

8.1 For the case where (a) the fatigue life data pertain to a random sample (all  $Y_i$  are independent), (b) there are neither run-outs nor suspended tests and where, for the entire interval of  $X$  used in testing, (c) the  $S$ - $N$  or  $\varepsilon$ - $N$  relationship is described by the linear model  $Y = A + BX$  (more precisely by  $\mu_{Y|X} = A + BX$ ), (d) the (two parameter) log-normal distribution describes the fatigue life  $N$ , and (e) the variance of the log-normal distribution is constant, the maximum likelihood estimators of  $A$  and  $B$  are as follows:

$$\hat{A} = \bar{Y} - \hat{B} \bar{X} \quad (4)$$

$$\hat{B} = \frac{\sum_{i=1}^k (X_i - \bar{X})(Y_i - \bar{Y})}{\sum_{i=1}^k (X_i - \bar{X})^2} \quad (5)$$

where the symbol “caret” ( $\hat{\phantom{x}}$ ) denotes estimate (estimator), the symbol “overbar” ( $\bar{\phantom{x}}$ ) denotes average (for example,  $\bar{Y} = \sum_{i=1}^k Y_i/k$  and  $\bar{X} = \sum_{i=1}^k X_i/k$ ),  $Y_i = \log N_i$ ,  $X_i = S_i$  or  $\varepsilon_i$ , or  $\log S_i$  or  $\log \varepsilon_i$  (refer to Eq 1 and Eq 2), and  $k$  is the total number of test specimens (the total sample size). The recommended expression for estimating the variance of the normal distribution for  $\log N$  is

$$\hat{\sigma}^2 = \frac{\sum_{i=1}^k (Y_i - \hat{Y}_i)^2}{k - 2} \quad (6)$$

in which  $\hat{Y}_i = \hat{A} + \hat{B}X_i$  and the  $(k - 2)$  term in the denominator is used instead of  $k$  to make  $\hat{\sigma}^2$  an unbiased estimator of the normal population variance  $\sigma^2$ .